


<b>Search Notes</b> 	<b>Application/Control No.</b> 10760610	<b>Applicant(s)/Patent Under Reexamination</b> SMITH, MARK JEFFREY
	<b>Examiner</b> Nguyen, Toan D	<b>Art Unit</b> 2616

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SEARCH NOTES		
Search Notes	Date	Examiner
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